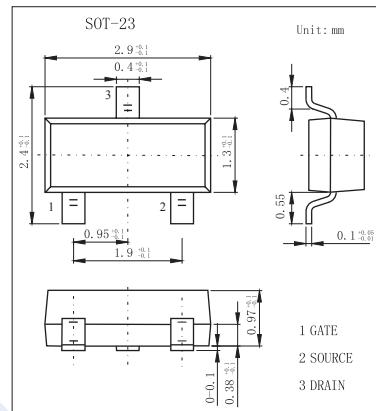
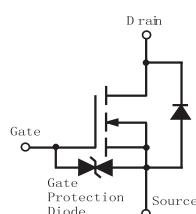


N-Channel Enhancement MOSFET

2KK5009

■ Features

- Low On-Resistance: $R_{DS(ON)}$
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- ESD Protected 2KV HBM

■ Absolute Maximum Ratings $T_a=25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage -Continuous	V_{GS}	± 20	
Drain Current -Continuous (Note:1)	I_D	440	mA
		1000	
Power Dissipation (Note 1)	P_D	530	mW
Thermal Resistance.Junction- to-Ambient	R_{thJA}	232	$^\circ\text{C}/\text{W}$
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	-55 to 150	

Notes: 1. Device mounted on FR-4 PCB using 1 square inch pad size, 1oz copper.

■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage (Note.2)	V_{DSS}	$I_D=100 \mu\text{A}$, $V_{GS}=0\text{V}$	60			V
Zero Gate Voltage Drain Current (Note.2)	I_{DSS}	$V_{DS}=60\text{V}$, $V_{GS}=0\text{V}$			1	μA
Gate-Body Leakage Current (Note.2)	I_{GSS}	$V_{DS}=0\text{V}$, $V_{GS}=\pm 20\text{V}$			± 10	
Gate Threshold Voltage (Note.2)	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=250 \mu\text{A}$	1	1.4	2.0	V
Static Drain-Source On-Resistance (Note.2)	$R_{DS(on)}$	$V_{GS}=10\text{V}$, $I_D=500\text{mA}$		1.4	2.0	Ω
		$V_{GS}=4.5\text{V}$, $I_D=200\text{mA}$		1.7	2.6	
Forward Transfer Admittance (Note.2)	$ Y_{fs} $	$V_{GS}=10\text{V}$, $I_D=200\text{mA}$	80			ms
Input Capacitance	C_{iss}	$V_{GS}=0\text{V}$, $V_{DS}=25\text{V}$, $f=1\text{MHz}$			50	pF
Output Capacitance	C_{oss}				25	
Reverse Transfer Capacitance	C_{rss}				5	
Total Gate Charge	Q_g	$V_{GS}=4.5\text{V}$, $V_{DS}=15\text{V}$, $I_D=200\text{mA}$			0.8	nC
Turn-On DelayTime	$t_{d(on)}$	$I_D=200\text{mA}$, $V_{DS}=30\text{V}$, $R_G=10\Omega$, $V_{GEN}=10\text{V}$, $R_L=150\Omega$			20	ns
Turn-Off DelayTime	$t_{d(off)}$				40	

Note: 2. Short duration test pulse used to minimize self-heating effect.

■ Marking

Marking	KA9
---------	-----

2KK5009

■ Typical Characteristics

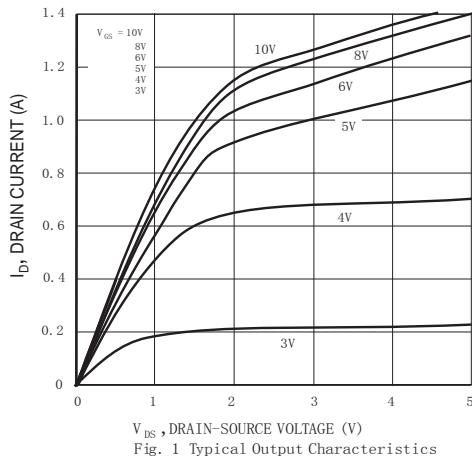


Fig. 1 Typical Output Characteristics

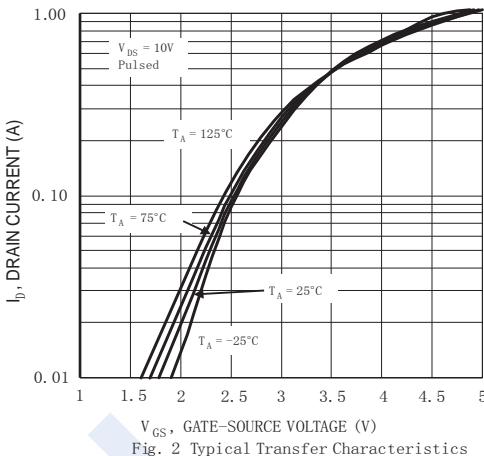


Fig. 2 Typical Transfer Characteristics

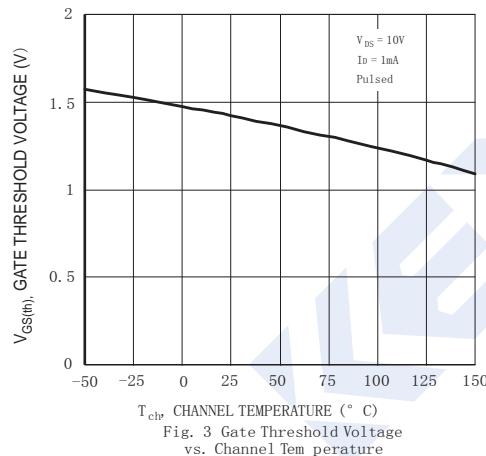


Fig. 3 Gate Threshold Voltage vs. Channel Temperature

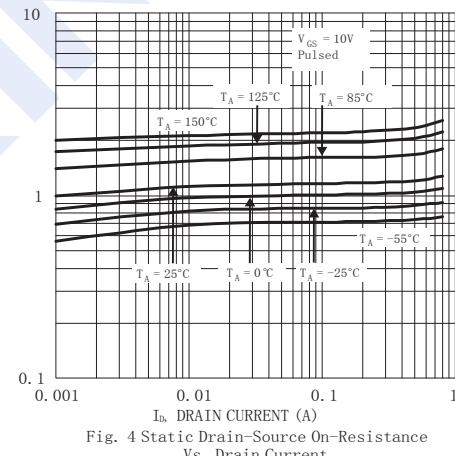


Fig. 4 Static Drain-Source On-Resistance vs. Drain Current

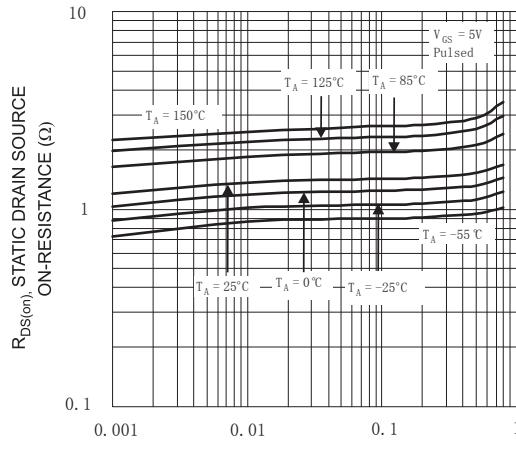


Fig. 5 Static Drain-Source On-Resistance vs. Drain Current

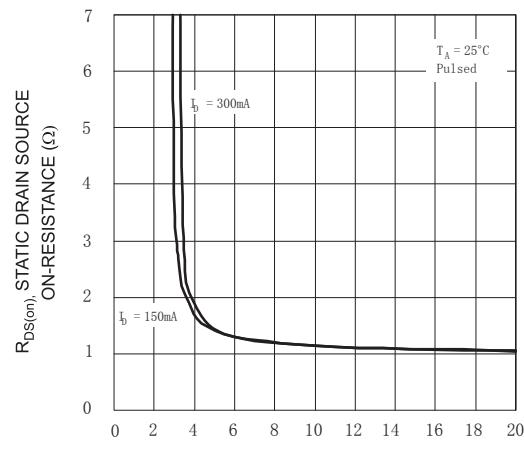
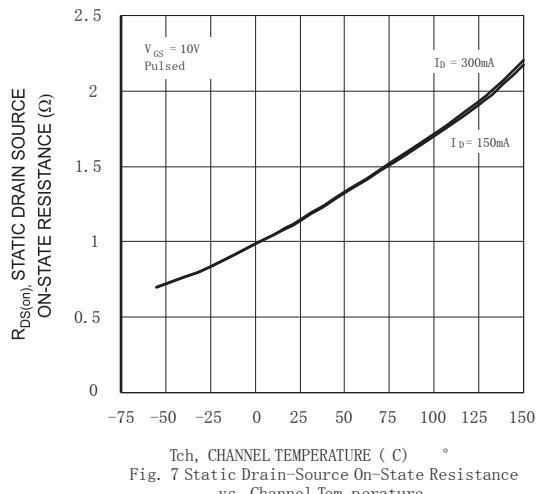
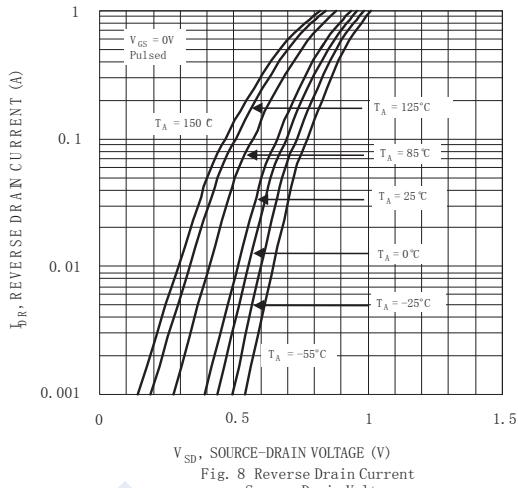


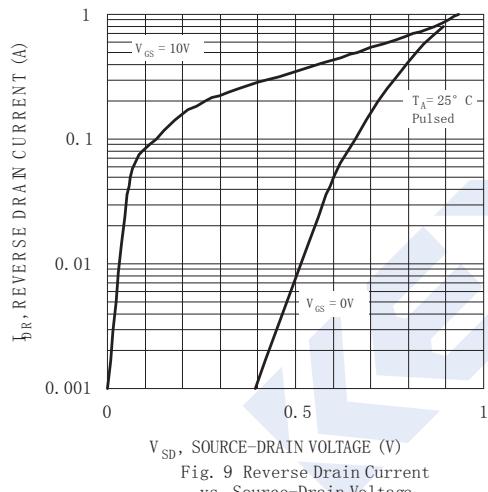
Fig. 6 Static Drain-Source On-Resistance vs. Gate-Source Voltage

2KK5009

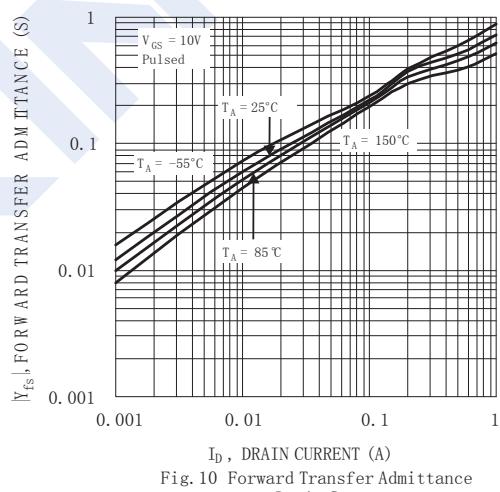
T_{ch}, CHANNEL TEMPERATURE (°C)
Fig. 7 Static Drain-Source On-State Resistance
vs. Channel Temperature



V_{SD}, SOURCE-DRAIN VOLTAGE (V)
Fig. 8 Reverse Drain Current
vs. Source-Drain Voltage



V_{SD}, SOURCE-DRAIN VOLTAGE (V)
Fig. 9 Reverse Drain Current
vs. Source-Drain Voltage



I_D, DRAIN CURRENT (A)
Fig. 10 Forward Transfer Admittance
vs. Drain Current